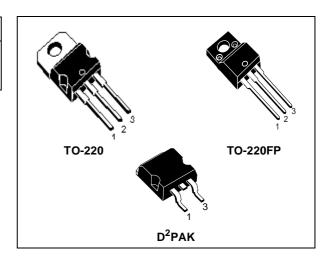


STP6NK60Z STP6NK60ZFP - STB6NK60Z

N-CHANNEL 600V - 1Ω - 6A TO-220/TO-220FP/D²PAK Zener-Protected SuperMESH[™]Power MOSFET

TYPE	V _{DSS}	R _{DS(on)}	I _D	Pw
STP6NK60Z	600 V	< 1.2 Ω	6 A	104 W
STP6NK60ZFP	600 V	< 1.2 Ω	6 A	32 W
STB6NK60Z	600 V	< 1.2 Ω	6 A	104 W

- TYPICAL $R_{DS}(on) = 1 \Omega$
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- GATE CHARGE MINIMIZED
- VERY LOW INTRINSIC CAPACITANCES
- VERY GOOD MANUFACTURING REPEATIBILITY

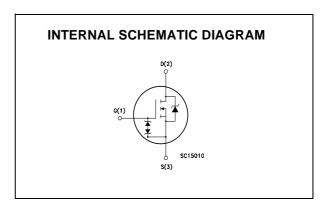


DESCRIPTION

The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- IDEAL FOR OFF-LINE POWER SUPPLIES, ADAPTORS AND PFC
- LIGHTING



ORDERING INFORMATION

SALES TYPE	MARKING	PACKAGE	PACKAGING
STP6NK60Z	P6NK60Z	TO-220	TUBE
STP6NK60ZFP	P6NK60ZFP	TO-220FP	TUBE
STB6NK60ZT4	B6NK60Z	D ² PAK	TAPE & REEL

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STP6NK60Z - STP6NK60ZFP - STB6NK60Z

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Valu	ıe	Unit
		STP6NK60Z STB6NK60Z	STP6NK60ZFP	
V _{DS}	Drain-source Voltage (V _{GS} = 0)	60	0	V
V_{DGR}	Drain-gate Voltage (R _{GS} = 20 kΩ)	60	0	V
V _{GS}	Gate- source Voltage	± 3	0	V
I _D	Drain Current (continuous) at T _C = 25°C	6	6 (*)	Α
I _D	Drain Current (continuous) at T _C = 100°C	3.8	3.8 (*)	Α
I _{DM} (•)	Drain Current (pulsed)	24	24 (*)	Α
P _{TOT}	Total Dissipation at T _C = 25°C	104	32	W
	Derating Factor	0.83	0.25	W/°C
V _{ESD(G-S)}	Gate source ESD(HBM-C=100pF, R=1.5KΩ)	350	00	V
dv/dt (1)	Peak Diode Recovery voltage slope	4.9	5	V/ns
V _{ISO}	Insulation Withstand Voltage (DC)	-	2500	V
T _j T _{stg}	Operating Junction Temperature Storage Temperature	-55 to 150 -55 to 150		°C

^(•) Pulse width limited by safe operating area

THERMAL DATA

		TO-220 / D ² PAK	TO-220FP	
Rthj-case	Thermal Resistance Junction-case Max	1.2	3.9	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	62.5	5	°C/W
T _I	Maximum Lead Temperature For Soldering Purpose	300	1	°C

AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max)	6	А
E _{AS}	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	210	mJ

GATE-SOURCE ZENER DIODE

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate-Source Breakdown Voltage	Igs=± 1mA (Open Drain)	30			V

PROTECTION FEATURES OF GATE-TO-SOURCE ZENER DIODES

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to souce. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

⁽¹⁾ $I_{SD} \leq 6A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_i \leq T_{JMAX}$.

^(*) Limited only by maximum temperature allowed

ELECTRICAL CHARACTERISTICS (TCASE =25°C UNLESS OTHERWISE SPECIFIED) ON/OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0	600			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating, T_{C} = 125 °C			1 50	μA μA
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20V			±10	μA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 100\mu A$	3	3.75	4.5	V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10V, I _D = 3 A		1	1.2	Ω

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g _{fs} (1)	Forward Transconductance	V _{DS} = 8 V, I _D = 3 A		5		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25V, f = 1 \text{ MHz}, V_{GS} = 0$		905 115 25		pF pF pF
Coss eq. (3)	Equivalent Output Capacitance	V _{GS} = 0V, V _{DS} = 0V to 480V		56		pF

SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on Delay Time Rise Time	$V_{DD} = 300 \text{ V}, I_D = 3 \text{ A}$ $R_G = 4.7\Omega \text{ V}_{GS} = 10 \text{ V}$ (Resistive Load see, Figure 3)		14 14		ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 480V, I_D = 6 A,$ $V_{GS} = 10V$		33 6 17	46	nC nC nC

SWITCHING OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(off)} t _f	Turn-off Delay Time Fall Time	V_{DD} = 300 V, I_D = 3 A R _G = 4.7 Ω V _{GS} = 10 V (Resistive Load see, Figure 3)		47 19		ns ns
$\begin{array}{c} t_{r(\text{Voff})} \\ t_{f} \\ t_{c} \end{array}$	Off-voltage Rise Time Fall Time Cross-over Time	$\begin{split} V_{DD} &= 480 \text{V, } I_D = 6 \text{ A,} \\ R_G &= 4.7 \Omega, V_{GS} = 10 \text{V} \\ \text{(Inductive Load see, Figure 5)} \end{split}$		16 16 29		ns ns ns

SOURCE DRAIN DIODE

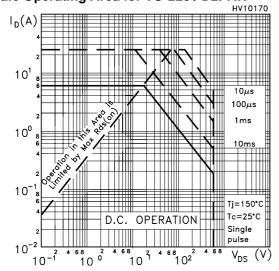
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} (2)	Source-drain Current Source-drain Current (pulsed)				6 24	A A
V _{SD} (1)	Forward On Voltage	I _{SD} = 6 A, V _{GS} = 0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 6$ A, di/dt = 100A/ μ s $V_{DD} = 50$ V, $T_j = 150$ °C (see test circuit, Figure 5)		445 2.7 12		ns μC A

Note: 1. Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.

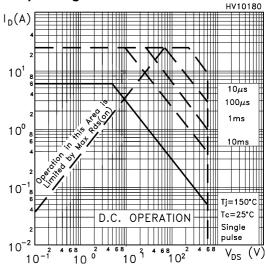
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^{1.} I dised. I dise duration = 300 µs, duty cycle 1.5 %.
2. Pulse width limited by safe operating area.
3. Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSs.

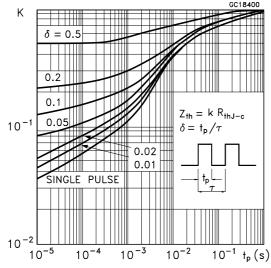
Safe Operating Area for TO-220 / D2PAK



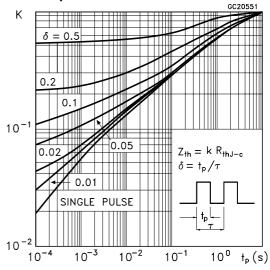
Safe Operating Area for TO-220FP



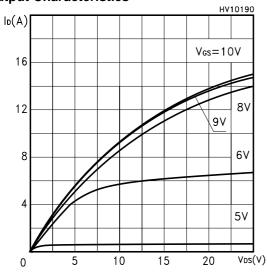
Thermal Impedance for TO-220 / D2PAK



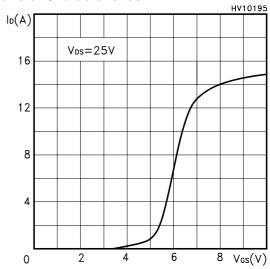
Thermal Impedance for TO-220FP



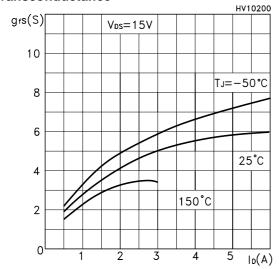
Output Characteristics



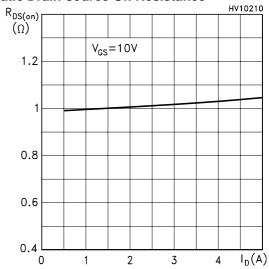
Transfer Characteristics



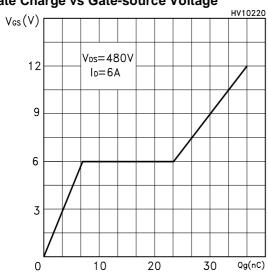
Transconductance



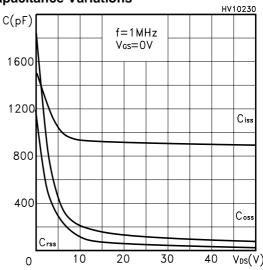
Static Drain-source On Resistance

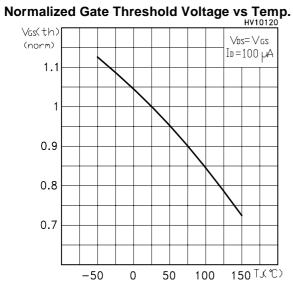


Gate Charge vs Gate-source Voltage

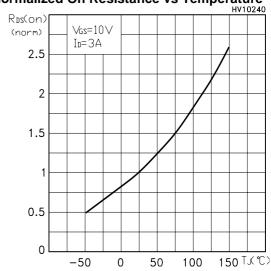


Capacitance Variations



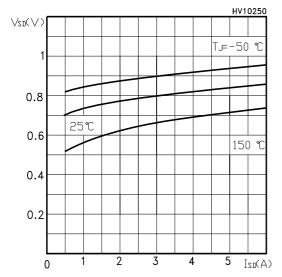


Normalized On Resistance vs Temperature



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Source-drain Diode Forward Characteristics



Normalized BVDSS vs Temperature

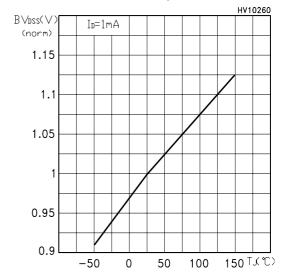


Fig. 1: Unclamped Inductive Load Test Circuit

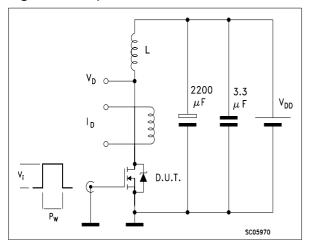


Fig. 3: Switching Times Test Circuit For Resistive Load

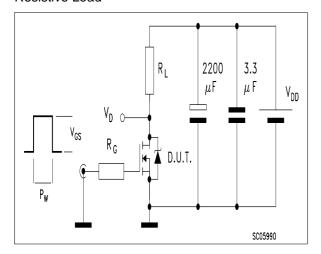


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

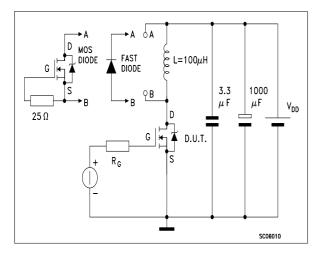


Fig. 2: Unclamped Inductive Waveform

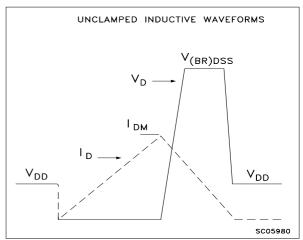
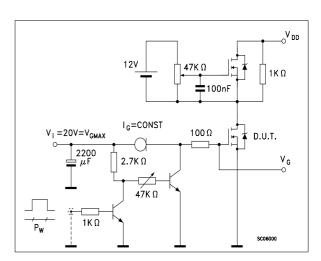
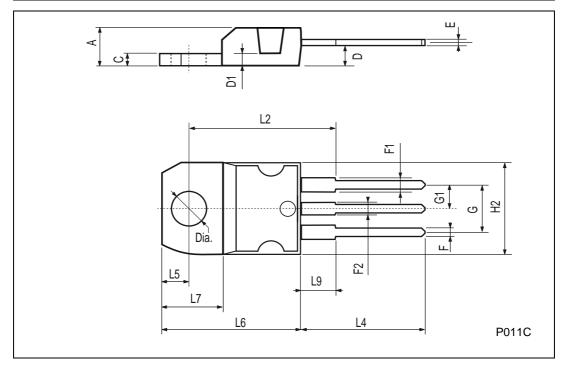


Fig. 4: Gate Charge test Circuit



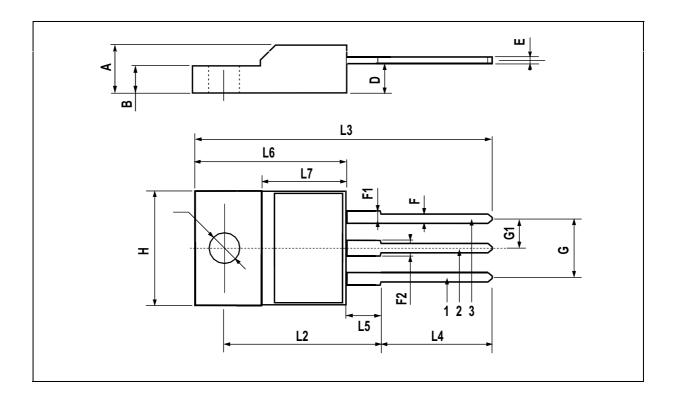
TO-220 MECHANICAL DATA

DIM.	mm			inch		
DIWI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	4.40		4.60	0.173		0.181
С	1.23		1.32	0.048		0.051
D	2.40		2.72	0.094		0.107
D1		1.27			0.050	
Е	0.49		0.70	0.019		0.027
F	0.61		0.88	0.024		0.034
F1	1.14		1.70	0.044		0.067
F2	1.14		1.70	0.044		0.067
G	4.95		5.15	0.194		0.203
G1	2.4		2.7	0.094		0.106
H2	10.0		10.40	0.393		0.409
L2		16.4			0.645	
L4	13.0		14.0	0.511		0.551
L5	2.65		2.95	0.104		0.116
L6	15.25		15.75	0.600		0.620
L7	6.2		6.6	0.244		0.260
L9	3.5		3.93	0.137		0.154
DIA.	3.75		3.85	0.147		0.151



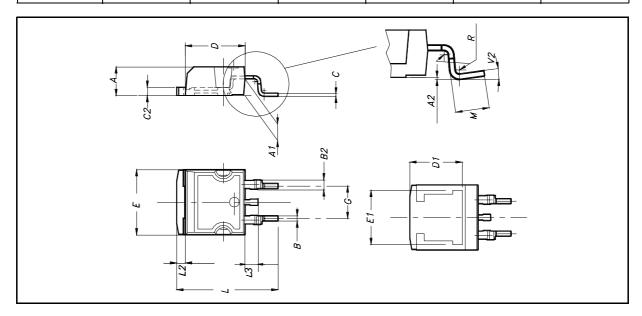
TO-220FP MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.5	0.045		0.067
F2	1.15		1.5	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



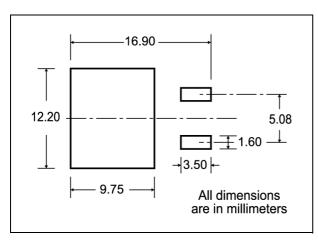
D²PAK MECHANICAL DATA

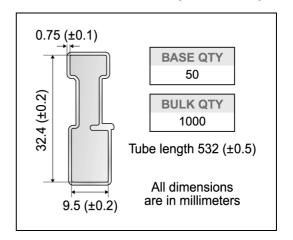
DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
В	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
С	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
Е	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
М	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	00		80			



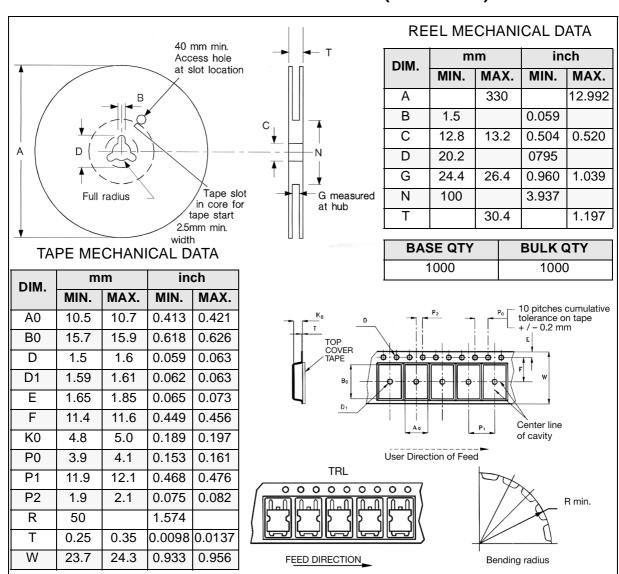
D²PAK FOOTPRINT

TUBE SHIPMENT (no suffix)*





TAPE AND REEL SHIPMENT (suffix "T4")*



* on sales type

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